

Suppressing the Photocatalytic Activity of TiO₂ Nanoparticles by Extremely Thin Al₂O₃ Films Grown by Gas-Phase Deposition at Ambient Conditions

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Supporting Information

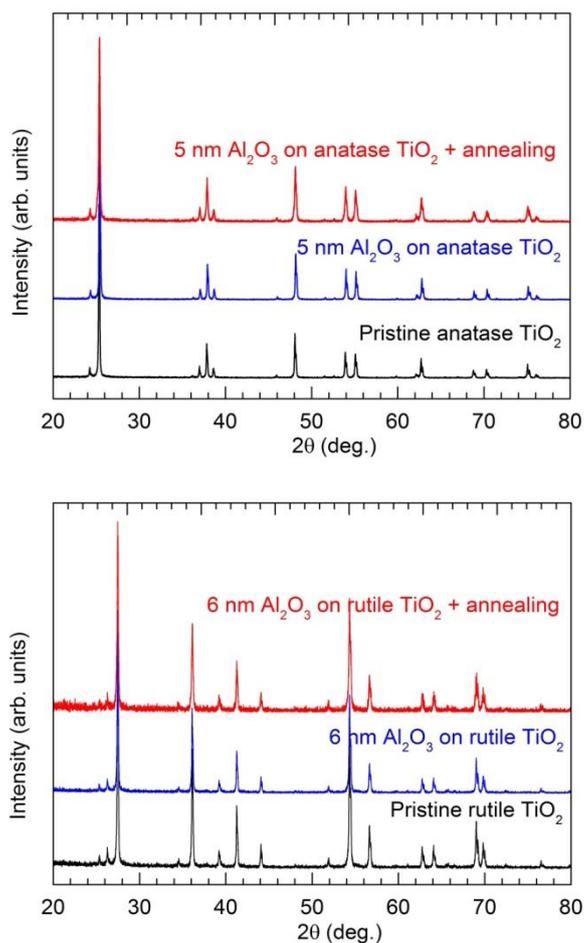


Figure S1. XRD patterns of uncoated TiO₂ and Al₂O₃-coated TiO₂, with or without annealing at 500 °C for 12 hours: anatase (top) and rutile (bottom). No signature of Al₂O₃ crystal phase was observed, suggesting the amorphous state of the coating layers. The coating has no effects on the crystalline structure of the TiO₂, even after the annealing.

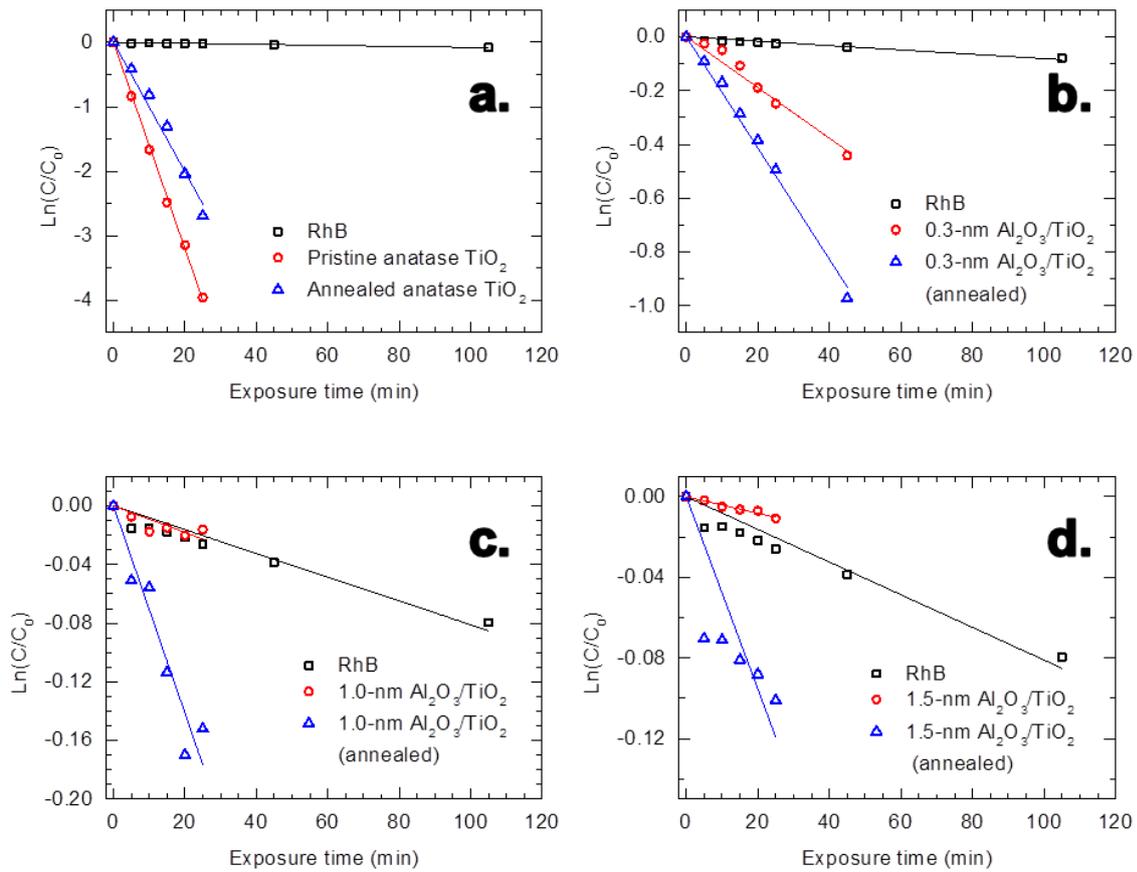


Figure S2. The comparison of photocatalytic activity of $\text{Al}_2\text{O}_3/\text{TiO}_2$ (anatase) powders before and after annealing at 500°C for 12 hours: (a) uncoated anatase TiO_2 ; (b) TiO_2 coated with 0.3 nm Al_2O_3 (i.e., 1 ALD cycle, this value of thickness is estimated based on the growth-per-cycle (GPC) of 0.3 nm); (c) TiO_2 coated with 1 nm Al_2O_3 ; and (d) TiO_2 coated with 1.5 nm Al_2O_3 . From these plots, it is better seen that the degradation of the TiO_2 coated with an Al_2O_3 layer with a thickness of about 1 nm is identical with the self-degradation of RhB. The lower slope obtained for 1.5-nm Al_2O_3 coated TiO_2 compared to blank RhB (Figure d) is due to the contribution of incomplete removal of the particles by centrifugation. In this case, the residual particles virtually act as an “extra amount of RhB” that detected by the UV-Vis measurement. This effect is only visible when the degradation caused by the photocatalyst is negligible.

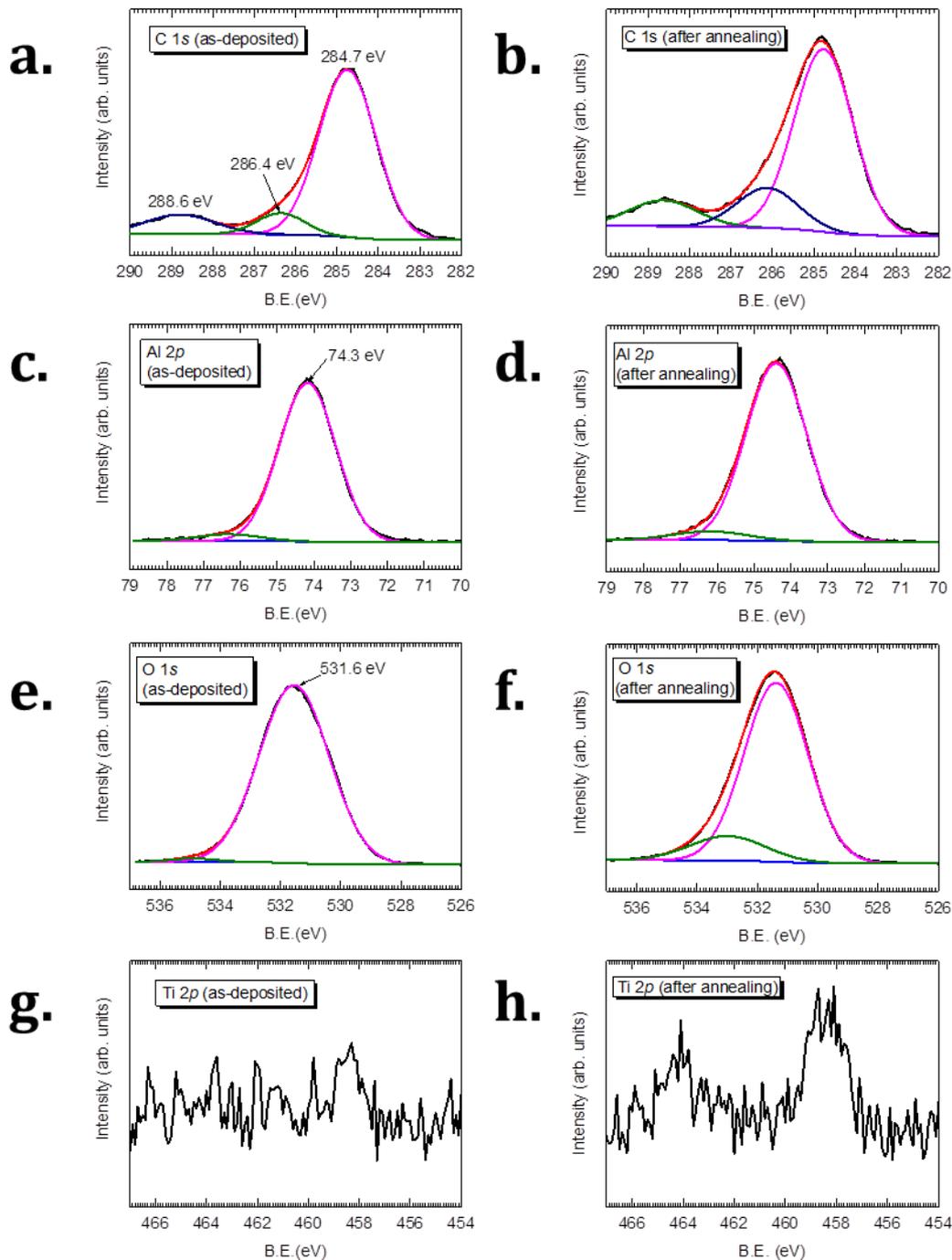


Figure S3. XPS spectra of C $1s$, Al $2p$, O $1s$ and Ti $2p$ core-levels of anatase TiO_2 coated with 5 nm Al_2O_3 : as-deposited (a, c, e & g) and after annealing at 500 °C for 12 hours in air (b, d, f & h). No significant changes were observed for the spectra of C $1s$ and Al $2p$ after annealing.

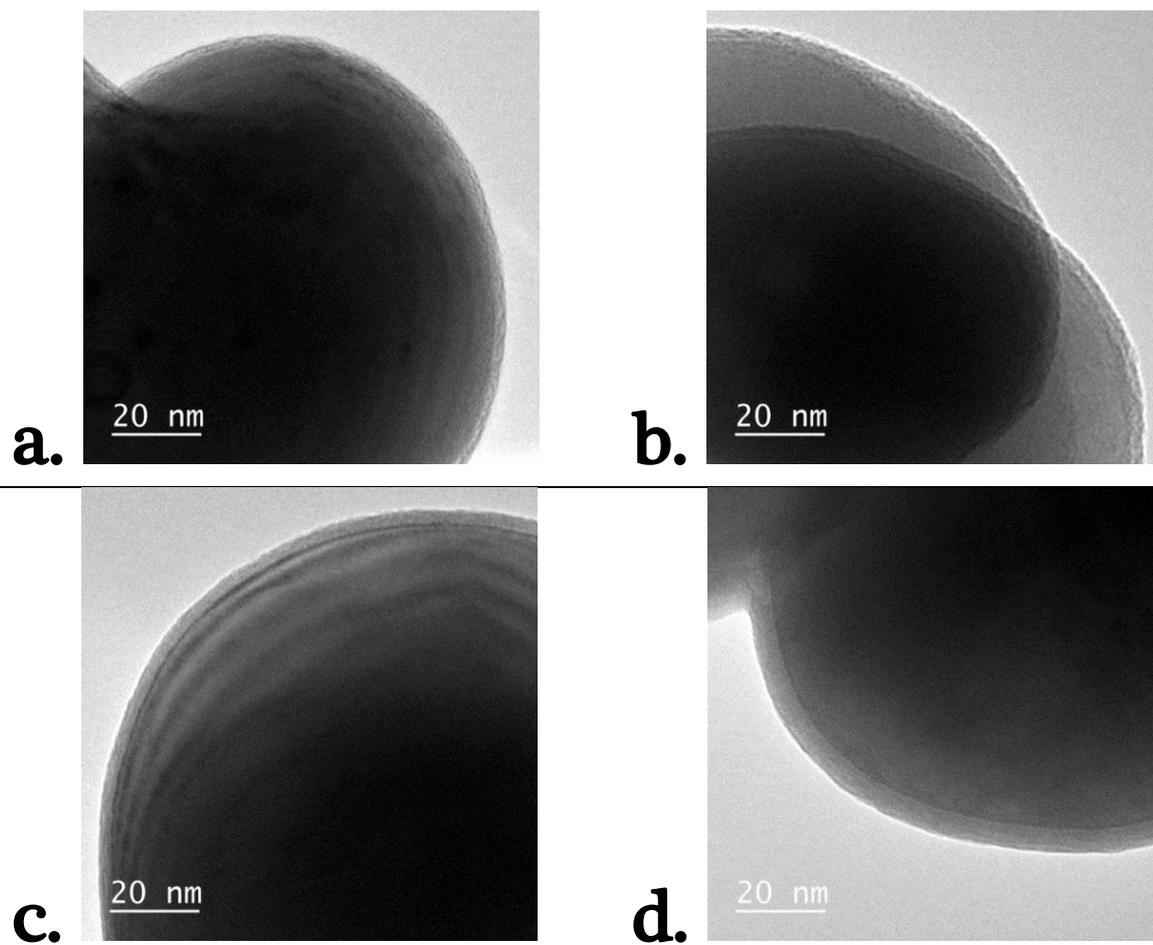


Figure S4. TEM micrographs of rutile TiO₂ coated with Al₂O₃ films deposited for (a) 3 cycles, (b) 5 cycles, (c) 10 cycles and (d) 17 cycles. The results demonstrate the growth of uniform Al₂O₃ films. A GPC of 0.34 nm was obtained for the deposition on rutile TiO₂ under the experimental conditions applied for the deposition on anatase TiO₂.

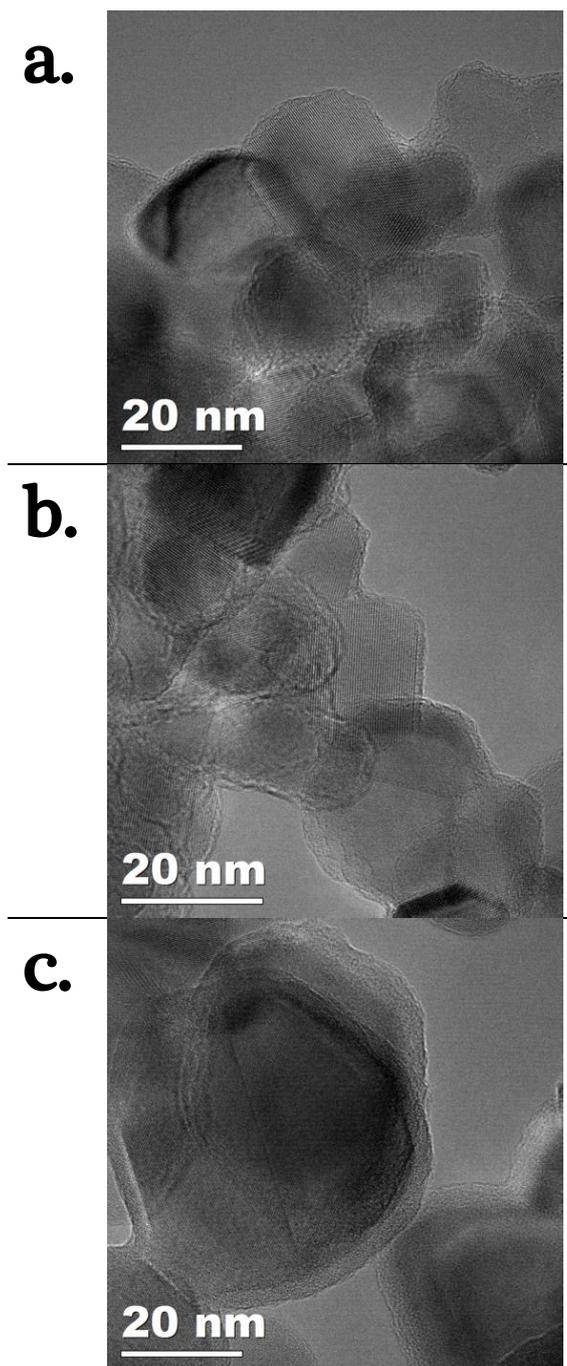


Figure S5. High-resolution TEM micrographs of P25 TiO₂ nanoparticles coated with Al₂O₃ for (a) 4 cycles, (b) 7 cycles and (c) 15 cycles. The growth mechanism on P25 TiO₂ was reported elsewhere.¹ We observed that, in comparison with the growth on anatase and rutile TiO₂, the uniformity of Al₂O₃ films on P25 TiO₂ nanoparticles is lower. Nevertheless, an Al₂O₃ layer with a thickness of approximately 1 nm obtained for 4 cycles could sufficiently suppress the high photocatalytic activity of the P25.

References

- (1) Valdesueiro et al., Gas-Phase Deposition of Ultrathin Aluminium Oxide Films on Nanoparticles at Ambient Conditions. *Materials* **2015**, *8*, 1249-1263.